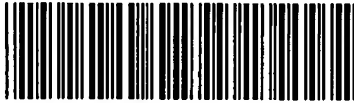


**Search Notes**

Application/Control No.

10/648,119

Examiner

Hanh Nguyen

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	241	10/12/2007	HN
	244		
	245		
	389		
	276		
	293		
	296		
	274		
	275		
370	255		
702	184		
	183		
702	182		
709	221		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
370	241	10/12/2007	HN
	255		
709	221		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	10/12/2007	HN